Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/624,327	LEE ET AL.
Examiner	Art Unit
Andy Huynh	2818

SEARCHED			
Class	Subclass	Date	Examiner
257	68,71	9/23/2004	AH
,	295-314		
	324-326		
438	3,240		
257	\$.ccls.	2/4/2005	АН
438	\$.ccls.		
365	\$.ccls.		
Text	search	2/4/2005	АН
Text	search	2/9/2005	АН
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
257	295,298	9/23/2004	АН
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438/3	3,240	9/23/2004	АН

	ARCH NOTES SEARCH STRATEC	SY)
	DATE	EXMR
EAST	9/23/2004	4 AH
EAST	2/4/2005	АН
EAST	2/9/2005	AH
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